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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/624,574	JUNG ET AL.	
Examiner	Art Unit	
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Class	Subclass	Date	Examiner
348	448, 449, 451, 452	3/21/2006	ML
	441		
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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	DATE	EXMR
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